Se	Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/773,640	CHEN ET AL.
Examiner	Art Unit
Syed Zaidi	2609

SEARCHED				
Class	Subclass	Date	Examiner	
370	446	4/11/2007	SZ	
370	465	4/11/2007	SZ	
370	464	4/11/2007	sz	
370	280	4/11/2007	SZ	
370	281	4/11/2007	SZ	
370	298	4/11/2007	SZ	
370	310	4/11/2007	SZ	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST image and keyword search in databases: uspat,us-pgpub,epo, jpo, ibm_tdb (see search strategy)	.4/11/2007	SZ
INVENTOR : Chen et al	4/11/2007	SZ
consulted SPE Rafael Perez Gutierrez & consulted Asst Hank Recla	4/11/2007	SZ
(370/446 370/464 370/464 370/280 370/281 370/298 370/310).cds.	4/11/2007	SZ